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ATTY DOCKET: FTIS 1001-1

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of Inventor:

Kathryn Marley

Christophe Pierrat et al.

Application No.: 10/616,603

Filed: 10 July 2003

Title: Contact or Proximity Printing Using a Magnified

Mask Image

Group Art Unit: not assigned

Examiner:

not assigned

Customer No. 22470

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. §1.56

Sir:

It is requested that the information identified in this statement be considered by the Examiner and made of record in the above-identified application. This statement is not intended to represent that a search has been made or that the information cited in the statement is, or is considered to be, material to patentability as defined in 37 C.F.R. 1.56.

Enclosed with this statement is a Form PTO-SB/08. The Examiner is requested to initial the form and return it to the undersigned in accordance with M.P.E.P. 609.

Also enclosed with this statement is a copy of each cited document as required by 37 C.F.R. 1.98.

This statement should be considered under 37 C.F.R. 1.97(b) because it is being filed within three months of the filing date of an application other than a continued prosecution application under 37 C.F.R. 1.53(d).

Fee Authorization. The Commissioner is hereby authorized to charge underpayment of any additional fees or credit any overpayment associated with this communication to Deposit Account No. 50-0869 (FTIS 1001-1). A duplicate copy of this authorization is enclosed.

Respectfully submitted,

HAYNES BEFFEL & WOLFELD LLP

12 ang 2003

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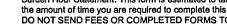
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Complete if Known				
Application Number	10/616,603			
Filing Date	10 July 2003			
First Named Inventor	Christophe Pierrat et al.			
Group Art Unit				
Examiner Name				
Attorney Docket Number	FTIS 1001-1			

			U.S. PATENT DOCU	JMENTS	
Examiner Initials	Cite No.1	U.S. Patent Document  Kind Code <sup>2</sup> (If known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	A1	5,121,256	Corle et al.	06-09-1992	
	A2	5,469,299	Nagano	11-21-1995	
	A3	5,982,558	Further et al.	11-09-1999	
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	A6				
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	Cite No. <sup>1</sup>	Office <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup> (if known)	Applicant of Cited Document	Cited Document MM-DD-YYYY	Passages or Relevant Figures Appear	T6
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Group Art Unit			
Examiner Name			

FTIS 1001-1

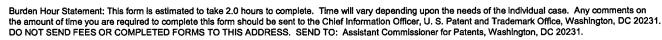
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<sup>&</sup>lt;sup>1</sup> Unique citation designation number. <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.





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